

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/814,838	JEFFRIES ET AL.	
Examiner		Art Unit		Page 1 of 1
Joiya M. Cloud		2144		

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,229,789 B1	05-2001	Simpson et al.	370/235
*	B	US-6,249,519 B1	06-2001	Rangachar, Suresh	370/356
*	C	US-2002/0118640 A1	08-2002	Oberman et al.	370/230
*	D	US-2003/0058880 A1	03-2003	Sarkinen et al.	370/413
*	E	US-2003/0172169 A1	09-2003	Cheng, Charles T.	709/230
*	F	US-2004/0003126 A1	01-2004	Boucher et al.	709/250
*	G	US-2004/0158640 A1	08-2004	Philbrick et al.	709/230
*	H	US-2005/0002334 A1	01-2005	Chao et al.	370/230
*	I	US-2006/0104281 A1	05-2006	Scarr et al.	370/395.1
*	J	US-7,177,276 B1	02-2007	Epps et al.	370/230
*	K	US-7,215,637 B1	05-2007	Ferguson et al.	370/230.1
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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